SCES052D - JULY 1995 - REVISED FEBRUARY 1999

- **Member of the Texas Instruments** Widebus™ Family
- **EPIC** ™ (Enhanced-Performance Implanted **CMOS) Submicron Process**
- **ESD Protection Exceeds 2000 V Per** MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- **Bus Hold on Data Inputs Eliminates the** Need for External Pullup/Pulldown Resistors
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL), Thin Shrink Small-Outline (DGG), and Thin Very Small-Outline (DGV) Packages

description

This 20-bit flip-flop is designed specifically for 1.65-V to 3.6-V V_{CC} operation.

The 20 flip-flops of the SN74ALVCH16721 are edge-triggered D-type flip-flops with qualified clock storage. On the positive transition of the clock (CLK) input, the device provides true data at the Q outputs if the clock-enable (CLKEN) input is low. If CLKEN is high, no data is stored.

A buffered output-enable (OE) input places the 20 outputs in either a normal logic state (high or low) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components. OE does not affect the internal operation of the flip-flops. Old data can be retained or new data can be entered while outputs are in the the high-impedance state.

DGG, DGV, OR DL PACKAGE (TOP VIEW)

	-			
OE [1	U	56	CLK
	2			D1
Q1 [3			D2
	1			
GND [4			GND
Q3 [5		52	_
Q4 [6		51	
V _{CC}	7		50	
Q5 [8			D5
_	9			D6
Q7 L	10			D7
GND [11			GND
Q8 [12		45	D8
Q9 [13		44] D9
Q10 [14		43	D10
Q11 [15		42	D11
Q12 [16		41	D12
Q13 [17		40	D13
GND [18		39	GND
Q14 [19		38	D14
Q15 [20			D15
Q16 [21		36	D16
v _{cc} [22		35	[v _{cc}
Q17 [23			_ ~~
Q18 [24			
GND [25		32	
Q19 [26		31	D19
Q20 [27		30	_
NC [28		29	CLKEN
	ت			r

NC - No internal connection

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVCH16721 is characterized for operation from -40°C to 85°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

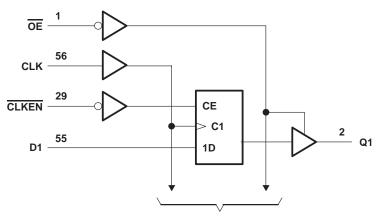
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FUNCTION TABLE (each flip-flop)

	INPL	OUTPUT		
OE	CLKEN	CLK	D	Q
L	Н	Х	Χ	Q ₀
L	L	\uparrow	Н	Н
L	L	\uparrow	L	L
L	L	L or H	Χ	Q ₀
н	Χ	X	X	Z

logic diagram (positive logic)



To 19 Other Channels

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}		–0.5 V to 4.6 V
Input voltage range, V _I (see Note 1)		–0.5 V to 4.6 V
Output voltage range, V _O (see Notes 1 and 2)		$0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$)		–50 mA
Output clamp current, I _{OK} (V _O < 0)		–50 mA
Continuous output current, IO		±50 mA
Continuous current through each V _{CC} or GND		±100 mA
Package thermal impedance, θ _{JA} (see Note 3)	: DGG package	81°C/W
	DGV package	86°C/W
	DL package	74°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. This value is limited to 4.6 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51.



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recommended operating conditions (see Note 4)

			MIN	MAX	UNIT	
Vcc	Supply voltage		1.65	3.6	V	
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	0.65 × V _{CC}			
۷ _{IH}	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V	
	/IL Low-level input voltage /I Input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2			
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		$0.35 \times V_{CC}$		
٧ _{IL}	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8		
٧ _I	Input voltage		0	VCC	V	
٧o	Output voltage		0	VCC	V	
		V _{CC} = 1.65 V		-4		
la	High lavel autout august	V _{CC} = 2.3 V		-12	A	
IOH	nign-iever output current	V _{CC} = 2.7 V		-12	mA	
	Input voltage Output voltage High-level output current Low-level output current	V _{CC} = 3 V		-24		
		V _{CC} = 1.65 V		4		
la.	Low-level output current	V _{CC} = 2.3 V	12		1	
lOL		V _{CC} = 2.7 V		12	mA	
		V _{CC} = 3 V		24		
Δt/Δν	Input transition rise or fall rate			10	ns/V	
T _A	Operating free-air temperature		-40	85	°C	

NOTE 4: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

SN74ALVCH16721 3.3-V 20-BIT FLIP-FLOP **WITH 3-STATE OUTPUTS**

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	VCC	MIN	TYP [†]	MAX	UNIT	
	I _{OH} = -100 μA	1.65 V to 3.6 V	V _{CC} -0.	.2			
	$I_{OH} = -4 \text{ mA}$	1.65 V	1.2				
	$I_{OH} = -6 \text{ mA}$	2.3 V	2				
VOH		2.3 V	1.7			V	
	I _{OH} = -12 mA	2.7 V	2.2				
		3 V	2.4				
	I _{OH} = -24 mA	3 V	2				
	I _{OL} = 100 μA	1.65 V to 3.6 V			0.2		
	I _{OL} = 4 mA	1.65 V			0.45		
l va.	I _{OL} = 6 mA	2.3 V			0.4	V	
VOL	10 40	2.3 V			0.7	V	
	I _{OL} = 12 mA	2.7 V			0.4		
	I _{OL} = 24 mA	3 V			0.55		
II	$V_I = V_{CC}$ or GND	3.6 V			±5		
	V _I = 0.58 V	1.65 V	25				
	V _I = 1.07 V	1.65 V	-25				
	V _I = 0.7 V	2.3 V	45				
I _I (hold)	V _I = 1.7 V	2.3 V	-45			μΑ	
	V _I = 0.8 V	3 V	75				
	V _I = 2 V	3 V	-75				
	$V_{I} = 0 \text{ to } 3.6 \text{ V}^{\ddagger}$	3.6 V			±500		
I _{OZ}	$V_O = V_{CC}$ or GND	3.6 V			±10	μΑ	
ICC	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V			40	μΑ	
ΔlCC	One input at V _{CC} – 0.6 V, Other inputs at V _{CC} or GND	3 V to 3.6 V			750	μΑ	
Control inputs	Vi – Voe or CND	221/		3.5		n.E	
C _i Data inputs	V _I = V _{CC} or GND	3.3 V	6		pF		
C _O Outputs	$V_O = V_{CC}$ or GND	3.3 V		7		pF	

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

			VCC =	1.8 V	V _{CC} =		VCC =	2.7 V	V _{CC} =		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
fclock	ck Clock frequency			§		150		150		150	MHz
t _W	Pulse duration, CLK high or low		§		3.3		3.3		3.3		ns
	t _{SU} Setup time	Data before CLK↑	§		4		3.6		3.1		ns
^l su		CLKEN before CLK↑	§		3.4		3.1		2.7		
t _h Hold time	Data after CLK↑	§		0		0		0			
	Hold liffle	CLKEN after CLK↑	§		0		0		0		ns

[§] This information was not available at the time of publication.



[†] All typical values are at V_{CC} = 3.3 V, T_A = 25°C. ‡ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

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switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

PARAMETER	FROM (INPUT)			1.8 V	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		UNIT
	(INFOT)	(001F01)	MIN	TYP	MIN	MAX	MIN	MAX	MIN	MAX	
f _{max}			†		150		150		150		MHz
t _{pd}	CLK	Q		†	1	5.6	1	5.1	1	4.3	ns
t _{en}	ŌĒ	Q		†	1	6.1	1	5.8	1	4.8	ns
t _{dis}	ŌĒ	Q		†	1	5.5	1	4.7	1	4.4	ns

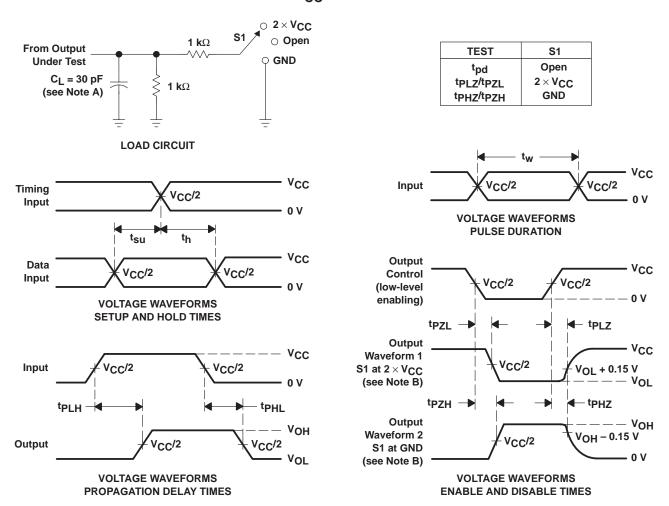
[†] This information was not available at the time of publication.

operating characteristics, T_A = 25°C

PARAMETER		TEST CONDITIONS	V _{CC} = 1.8 V V _{CC} = 2.5 V V		V _{CC} = 3.3 V	UNIT		
	FARAWIETER		TEST CONDITIONS	TYP	TYP	TYP	UNIT	
	Power dissipation	Outputs enabled	C ₁ = 50 pF. f = 10 MHz	†	55	59	pF	
C _{pd}	capacitance	Outputs disabled	$C_L = 50 \text{ pF}, f = 10 \text{ MHz}$	†	46	49	pr	

[†] This information was not available at the time of publication.

PARAMETER MEASUREMENT INFORMATION V_{CC} = 1.8 V

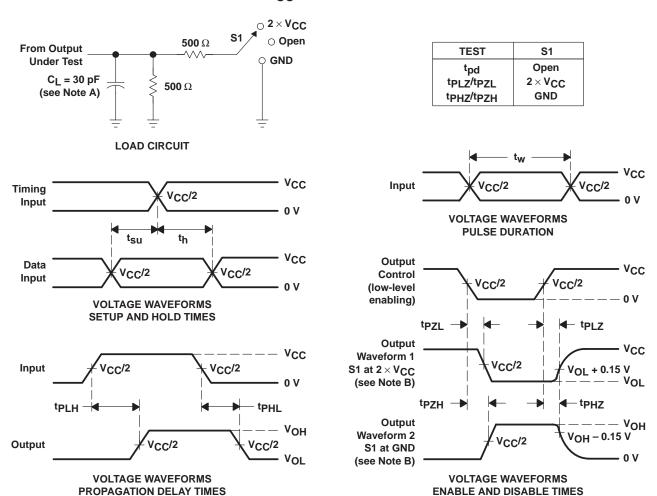


- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_Q = 50 \Omega$, $t_f \leq$ 2 ns, $t_f \leq$ 2 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpLZ and tpHZ are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



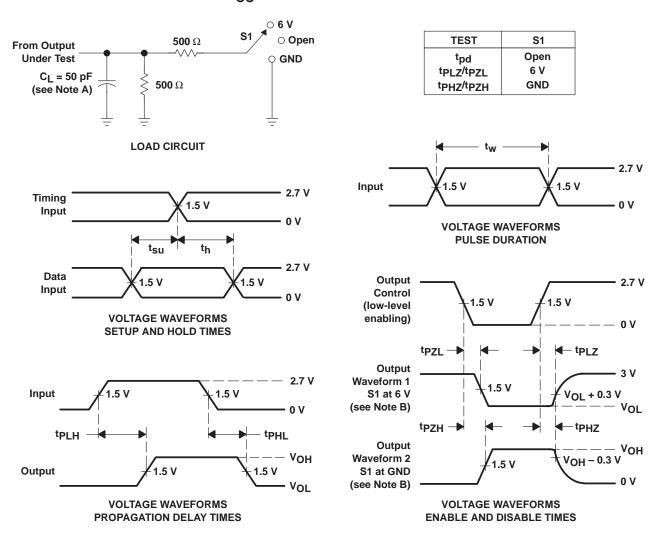
PARAMETER MEASUREMENT INFORMATION $V_{CC} = 2.5 V \pm 0.2 V$



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_Q = 50 \Omega$, $t_f \leq$ 2 ns, $t_f \leq$ 2 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpLZ and tpHZ are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tplH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION V_{CC} = 2.7 V AND 3.3 V \pm 0.3 V



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , $t_r \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpl 7 and tpH7 are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tpLH and tpHL are the same as tpd.

Figure 3. Load Circuit and Voltage Waveforms



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